

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/648,474	SHUSTER ET AL.	
Examiner	Art Unit	
DUSTIN NGUYEN	2454	

	SEVD	CHED				
	SEARCHED					
Class	Subclass	Date	Examiner			

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
709	200	2/11/2010	DN			
715	700	2/11/2010	DN			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
update EAST search, internet search (IEEE, ACM)	2/11/2010	DN